Search Notes

10/526,397 Examiner

Wayne Langel

Applicant(s)/Patent under Reexamination

TAKATSU ET AL.

Art Unit

1754

SEARCHED					
Class	Subclass	Date	Examiner		
502	400	12-5-06	WAL		
42-3	650	12506	WAL		
423	65/	12-5-06	MAL		
423	652	12-5-06	WAL		
423	653	12-5-06	WAL		
423	654	125-06	WAL		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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